

<b>Search Notes</b> 	<b>Application/Control No.</b> 09/651,944	<b>Applicant(s)/Patent under Reexamination</b> DRAPKIN ET AL.
	<b>Examiner</b> Hiep Nguyen	<b>Art Unit</b> 2816

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PG PUB search		5/4/2006	HN